

Notice of References Cited	Application/Control No. 09/589,633	Applicant(s)/Patent Under Reexamination NGUYEN ET AL.	
	Examiner Kiley Stoner	Art Unit 1725	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0190408	12-2002	Houston et al.	264/10
	B	US-2002/0006769	01-2002	Tsuihiji et al.	451/53
	C	US-2001/0041374	11-2001	Hintermaier et al.	438/3
	D	US-5,240,556	08-1993	Ishikawa et al.	216/67
	E	US-5,045,703	09-1991	Wieboldt et al.	250/352
	F	US-4,413,675	11-1983	Gano, Lloyd D.	165/119
	G	US-4,973,002	11-1990	Waller et al.	241/46.17
	H	US-5,015,503	05-1991	Varrin et al.	117/99
	I	US-4,468,001	08-1984	Stanic, Miodrag	251/86
	J	US-6,107,198	08-2000	Lin et al.	438/680
	K	US-6,299,513	10-2001	Tsuihiji et al.	451/88
	L	US-6,402,806	06-2002	Schmitt et al.	75/414
	M	US-6,099,649	08-2000	Schmitt et al.	118/715

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP-02001126999A	05-2001	JP	Y9magg	
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	DERWENT - ACC - No. 2003-137366 AHNet al.
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.